

SEMiX151GB17E4s



SEMiX® 1s

SEMiX151GB17E4s

Features

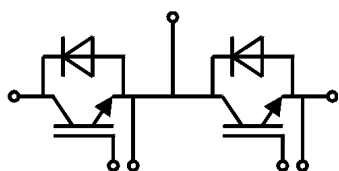
- Homogeneous Si
- Trench = Trenchgate technology
- $V_{CE(sat)}$ with positive temperature coefficient
- High short circuit capability
- UL recognized, file no. E63532

Typical Applications*

- AC inverter drives
- UPS
- Electronic Welding

Remarks

- Case temperature limited to $T_C=125\text{ °C}$ max.
- Product reliability results are valid for $T_j=150\text{ °C}$



GB

| Absolute Maximum Ratings | | | |
|--------------------------|---|-----------------------|--------------------|
| Symbol | Conditions | Values | Unit |
| IGBT | | | |
| V_{CES} | $T_j = 25\text{ °C}$ | 1700 | V |
| I_C | $T_j = 175\text{ °C}$ | $T_c = 25\text{ °C}$ | 260 |
| | | $T_c = 80\text{ °C}$ | 198 |
| I_{Cnom} | | 150 | A |
| I_{CRM} | $I_{CRM} = 3 \times I_{Cnom}$ | 450 | A |
| V_{GES} | | -20 ... 20 | V |
| t_{psc} | $V_{CC} = 1000\text{ V}$ $V_{GE} \leq 15\text{ V}$ $V_{CES} \leq 1700\text{ V}$ | $T_j = 150\text{ °C}$ | 10 |
| | | | μs |
| T_j | | -40 ... 175 | $^{\circ}\text{C}$ |
| Inverse diode | | | |
| V_{RRM} | $T_j = 25\text{ °C}$ | 1700 | V |
| I_F | $T_j = 175\text{ °C}$ | $T_c = 25\text{ °C}$ | 169 |
| | | $T_c = 80\text{ °C}$ | 125 |
| I_{Fnom} | | 150 | A |
| I_{FRM} | $I_{FRM} = 2 \times I_{Fnom}$ | 300 | A |
| I_{FSM} | $t_p = 10\text{ ms, sin } 180^{\circ}, T_j = 25\text{ °C}$ | 950 | A |
| T_j | | -40 ... 175 | $^{\circ}\text{C}$ |
| Module | | | |
| $I_{t(RMS)}$ | | 600 | A |
| T_{stg} | | -40 ... 125 | $^{\circ}\text{C}$ |
| V_{isol} | AC sinus 50Hz, $t = 1\text{ min}$ | 4000 | V |

| Characteristics | | | | | |
|-----------------|---|-----------------------|------|------|------------------|
| Symbol | Conditions | min. | typ. | max. | Unit |
| IGBT | | | | | |
| $V_{CE(sat)}$ | $I_C = 150\text{ A}$ $V_{GE} = 15\text{ V}$ chipelevel | $T_j = 25\text{ °C}$ | 1.90 | 2.20 | V |
| | | $T_j = 150\text{ °C}$ | 2.25 | 2.45 | V |
| V_{CE0} | chipelevel | $T_j = 25\text{ °C}$ | 1.1 | 1.2 | V |
| | | $T_j = 150\text{ °C}$ | 1 | 1.1 | V |
| r_{CE} | $V_{GE} = 15\text{ V}$ chipelevel | $T_j = 25\text{ °C}$ | 5.3 | 6.7 | $\text{m}\Omega$ |
| | | $T_j = 150\text{ °C}$ | 8.3 | 9 | $\text{m}\Omega$ |
| $V_{GE(th)}$ | $V_{GE}=V_{CE}, I_C = 6\text{ mA}$ | 5.2 | 5.8 | 6.4 | V |
| I_{CES} | $V_{GE} = 0\text{ V}$ $V_{CE} = 1700\text{ V}$ | $T_j = 25\text{ °C}$ | | 2 | mA |
| | | | | | mA |
| C_{ies} | $V_{CE} = 25\text{ V}$ | | 12 | | nF |
| C_{oes} | $V_{GE} = 0\text{ V}$ | | 0.50 | | nF |
| C_{res} | | | 0.38 | | nF |
| Q_G | $V_{GE} = -8\text{ V...} + 15\text{ V}$ | | 1200 | | nC |
| R_{Gint} | $T_j = 25\text{ °C}$ | | 5.00 | | Ω |
| $t_{d(on)}$ | $V_{CC} = 1200\text{ V}$ | | 210 | | ns |
| t_r | $I_C = 150\text{ A}$ $V_{GE} = +15/-15\text{ V}$ | $T_j = 150\text{ °C}$ | 28 | | ns |
| | | | | | |
| E_{on} | $R_{Gon} = 1\text{ }\Omega$ | | 52 | | mJ |
| $t_{d(off)}$ | $R_{Goff} = 1\text{ }\Omega$ | | 670 | | ns |
| t_f | $di/dt_{on} = 6400\text{ A}/\mu\text{s}$ $di/dt_{off} = 840\text{ A}/\mu\text{s}$ $du/dt = 5000\text{ V}/\mu\text{s}$ $L_s = 30\text{ nH}$ | $T_j = 150\text{ °C}$ | 150 | | ns |
| | | | | | |
| E_{off} | | | 60 | | mJ |

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| Characteristics | | | | | | |
|-----------------|--|-----------------------|------|------|-------|------|
| Symbol | Conditions | | min. | typ. | max. | Unit |
| $t_{d(on)}$ | $V_{CC} = 900\text{ V}$ | $T_j = 150\text{ °C}$ | | 210 | | ns |
| t_r | $I_C = 150\text{ A}$ | $T_j = 150\text{ °C}$ | | 47 | | ns |
| E_{on} | $V_{GE} = +15/-15\text{ V}$ | $T_j = 150\text{ °C}$ | | 28 | | mJ |
| $t_{d(off)}$ | $R_{G\ on} = 1\ \Omega$ | $T_j = 150\text{ °C}$ | | 620 | | ns |
| t_f | $R_{G\ off} = 1\ \Omega$ | $T_j = 150\text{ °C}$ | | 160 | | ns |
| E_{off} | $di/dt_{on} = 3500\text{ A}/\mu\text{s}$ | $T_j = 150\text{ °C}$ | | | | |
| | $di/dt_{off} = 800\text{ A}/\mu\text{s}$ | | | | | |
| | $du/dt = 4400\text{ V}/\mu\text{s}$ | | | 49 | | mJ |
| | $L_s = 80\text{ nH}$ | | | | | |
| $R_{th(j-c)}$ | per IGBT | | | | 0.162 | K/W |

| Characteristics | | | | | | |
|---------------------------|--|-----------------------|------|----------------|-------|---------------|
| Symbol | Conditions | | min. | typ. | max. | Unit |
| Inverse diode | | | | | | |
| $V_F = V_{EC}$ | $I_F = 150\text{ A}$ | $T_j = 25\text{ °C}$ | | 1.98 | 2.37 | V |
| | $V_{GE} = 0\text{ V}$ | $T_j = 150\text{ °C}$ | | 2.11 | 2.52 | V |
| | chipllevel | | | | | |
| V_{F0} | | $T_j = 25\text{ °C}$ | 1.16 | 1.32 | 1.56 | V |
| | chipllevel | $T_j = 150\text{ °C}$ | | 1.08 | 1.22 | V |
| r_F | | $T_j = 25\text{ °C}$ | 3.5 | 4.4 | 5.4 | m Ω |
| | chipllevel | $T_j = 150\text{ °C}$ | | 6.9 | 8.7 | m Ω |
| I_{RRM} | $I_F = 150\text{ A}$ | $T_j = 150\text{ °C}$ | | 200 | | A |
| Q_{rr} | $di/dt_{off} = 5500\text{ A}/\mu\text{s}$ | $T_j = 150\text{ °C}$ | | 56 | | μC |
| E_{rr} | $V_{GE} = -15\text{ V}$ | $T_j = 150\text{ °C}$ | | 41 | | mJ |
| | $V_R = 1200\text{ V}$ | | | | | |
| I_{RRM} | $I_F = 150\text{ A}$ | $T_j = 150\text{ °C}$ | | 190 | | A |
| Q_{rr} | $di/dt_{off} = 3200\text{ A}/\mu\text{s}$ | $T_j = 150\text{ °C}$ | | 54 | | μC |
| E_{rr} | $V_{GE} = -15\text{ V}$ | $T_j = 150\text{ °C}$ | | 34 | | mJ |
| | $V_R = 900\text{ V}$ | | | | | |
| $R_{th(j-c)}$ | per diode | | | | 0.345 | K/W |
| Module | | | | | | |
| L_{CE} | | | | 16 | | nH |
| $R_{CC'+EE'}$ | res. terminal-chip | $T_C = 25\text{ °C}$ | | 0.7 | | m Ω |
| | | $T_C = 125\text{ °C}$ | | 1 | | m Ω |
| $R_{th(c-s)}$ | per module | | | 0.075 | | K/W |
| M_s | to heat sink (M5) | | 3 | | 5 | Nm |
| M_t | | to terminals (M6) | 2.5 | | 5 | Nm |
| | | | | | | Nm |
| w | | | | | 145 | g |
| Temperature Sensor | | | | | | |
| R_{100} | $T_C = 100\text{ °C}$ ($R_{25} = 5\text{ k}\Omega$) | | | $493 \pm 5\%$ | | Ω |
| $B_{100/125}$ | $R(T) = R_{100} \exp[B_{100/125}(1/T - 1/T_{100})]$; $T[K]$; | | | $3550 \pm 2\%$ | | K |



GB

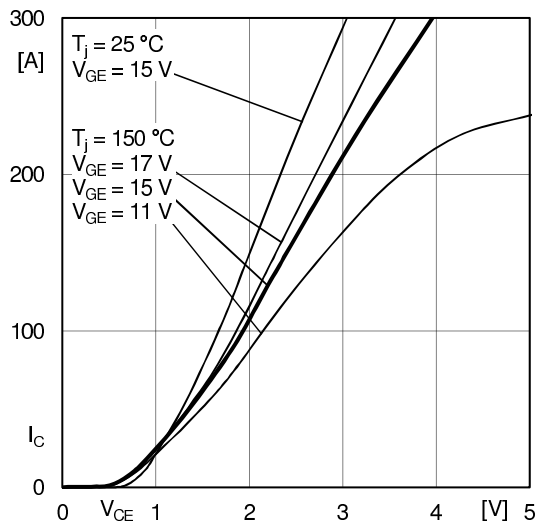


Fig. 1: Typ. output characteristic, inclusive R_{CC+EE}

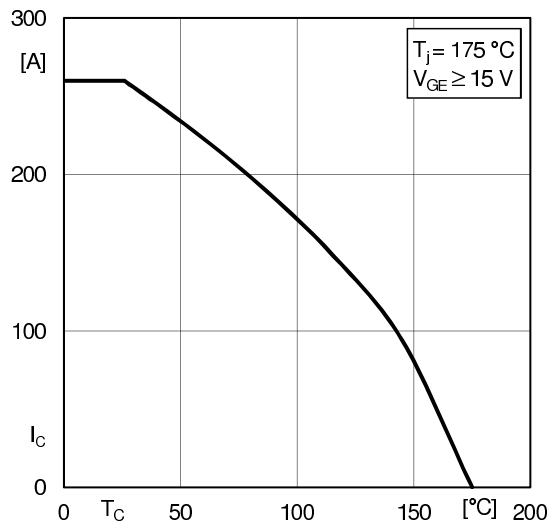


Fig. 2: Rated current vs. temperature $I_C = f(T_C)$

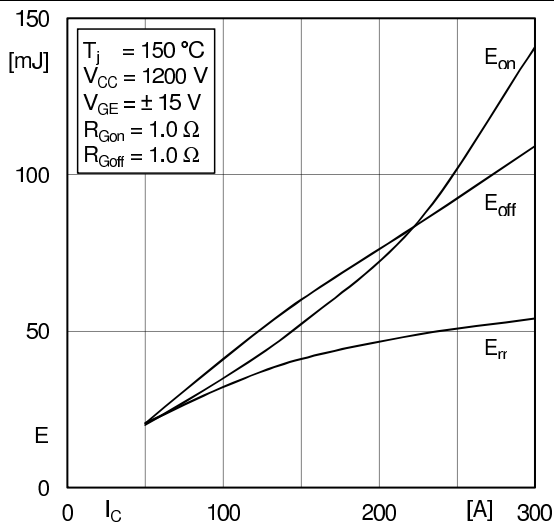


Fig. 3: Typ. turn-on /-off energy = $f(I_C)$

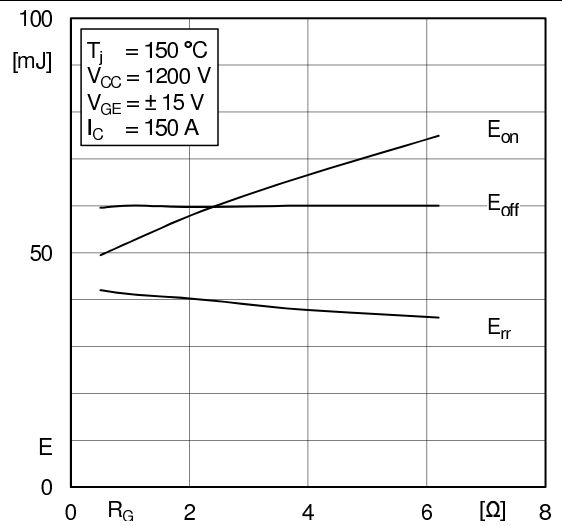


Fig. 4: Typ. turn-on /-off energy = $f(R_G)$

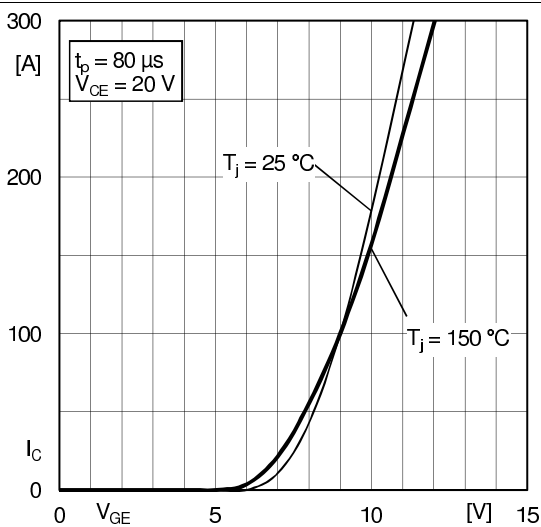


Fig. 5: Typ. transfer characteristic

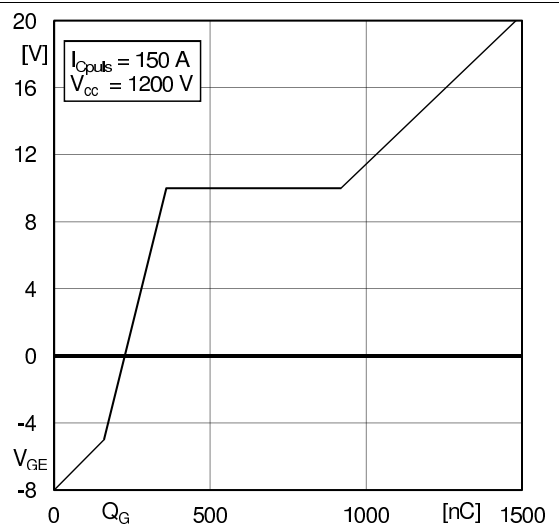
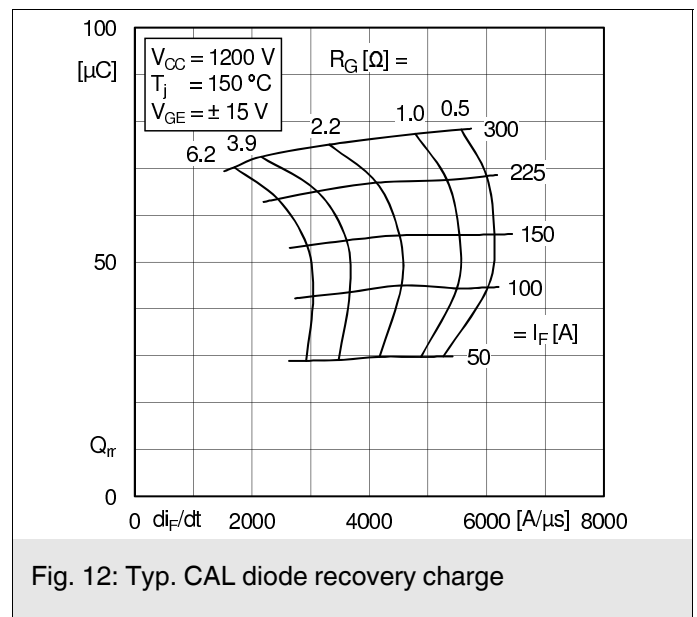
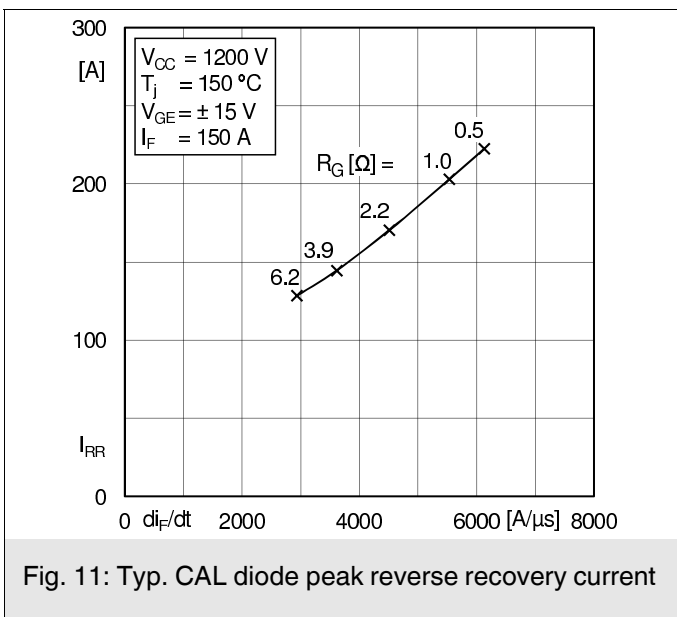
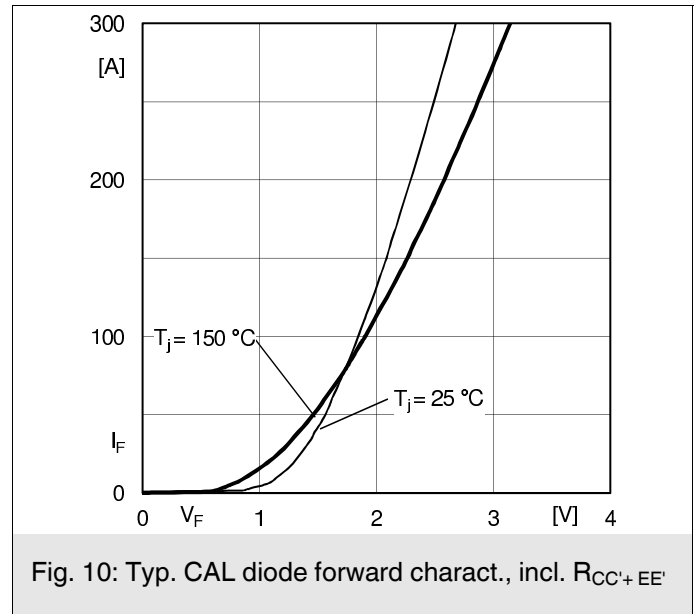
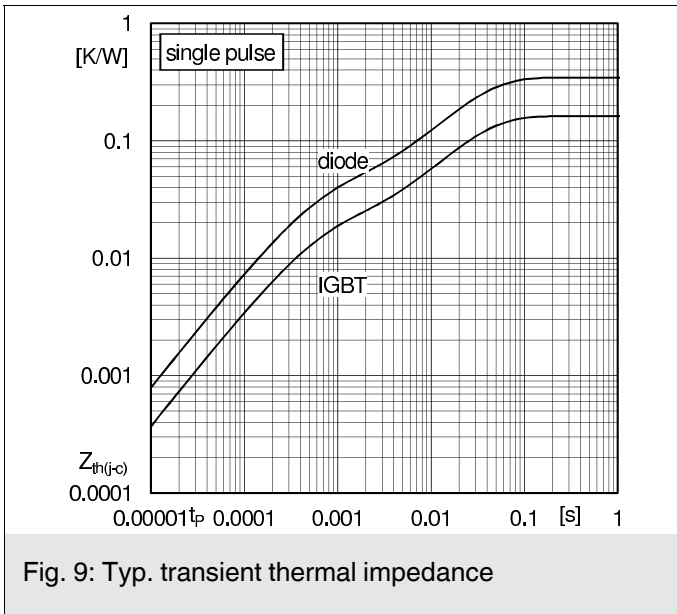
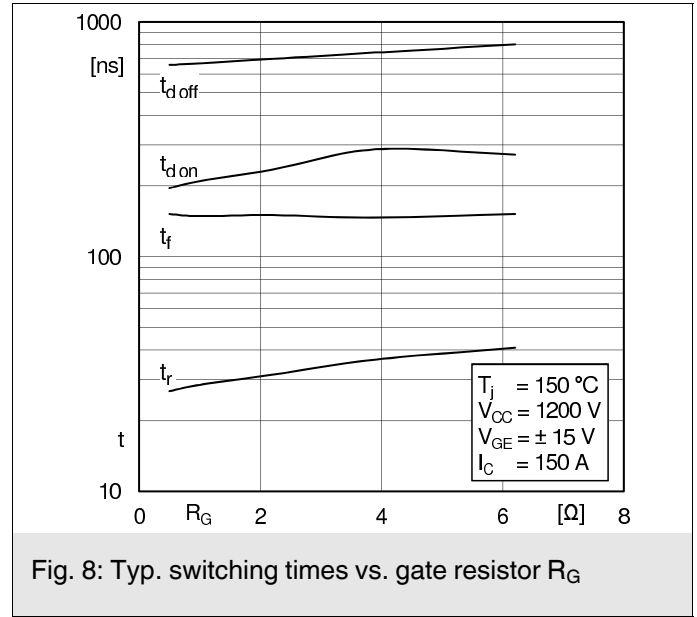
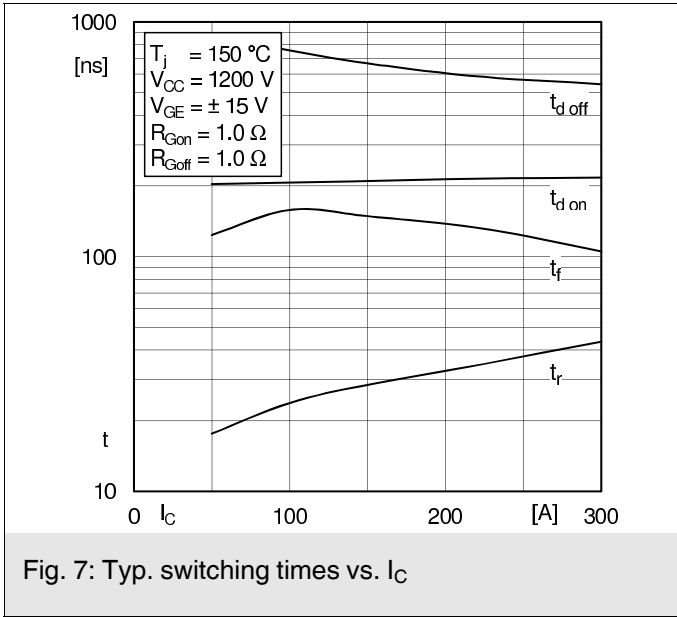


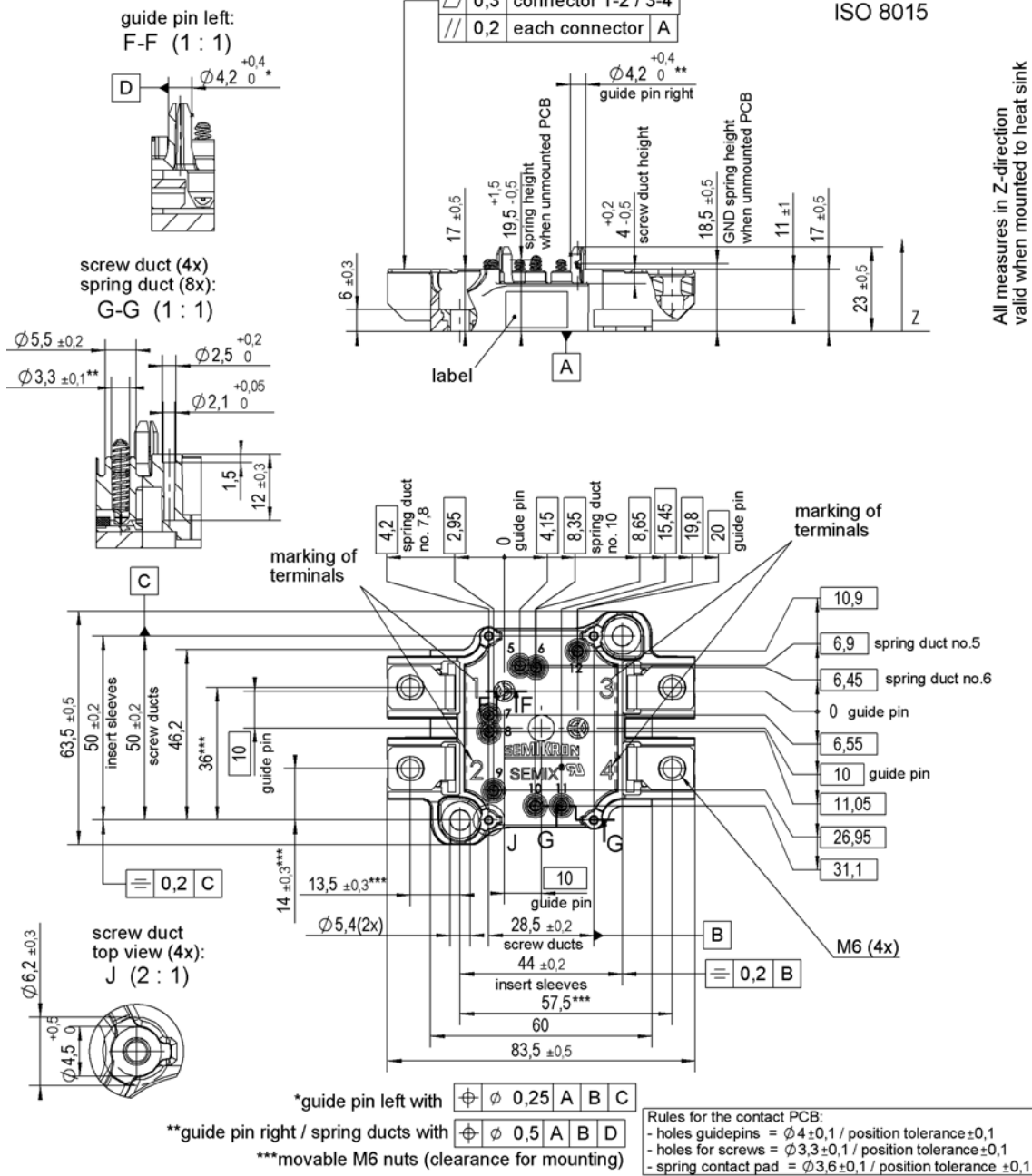
Fig. 6: Typ. gate charge characteristic



SEMiX151GB17E4s

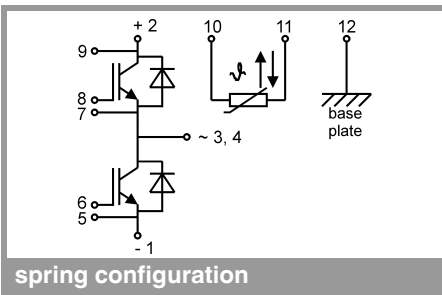
Case: SEMiX 1s

general tolerance:
ISO 2768-m
ISO 8015



All measures in Z-direction
valid when mounted to heat sink

SEMIX 1s



This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX

* The specifications of our components may not be considered as an assurance of component characteristics. Components have to be tested for the respective application. Adjustments may be necessary. The use of SEMIKRON products in life support appliances and systems is subject to prior specification and written approval by SEMIKRON. We therefore strongly recommend prior consultation of our staff.